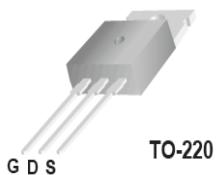


TSP60R850S1

600V 5A N-Channel SJ-MOSFET

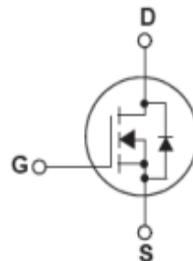
General Description

Truesemi SJ-FET is new generation of high voltage MOSFET family that is utilizing an advanced charge balance mechanism for outstanding low on-resistance and lower gate charge performance. This advanced technology has been tailored to minimize conduction loss, provide superior switching performance, and withstand extreme dv/dt rate and higher avalanche energy. SJ-FET is suitable for various AC/DC power conversion in switching mode operation for higher efficiency.



Features

- 650V @ $T_J = 150\text{ }^{\circ}\text{C}$
- Typ. $R_{DS(on)} = 0.77\Omega$
- Ultra Low gate charge (typ. $Q_g = 15\text{nC}$)
- 100% avalanche tested



Absolute Maximum Ratings

| Symbol | Parameter | Value | Unit |
|----------------|--|-------------|--------------------|
| V_{DSS} | Drain-Source Voltage | 600 | V |
| I_D | Drain Current -Continuous ($T_C = 25\text{ }^{\circ}\text{C}$) | 5* | A |
| | -Continuous ($T_C = 100\text{ }^{\circ}\text{C}$) | 3.2* | |
| I_{DM} | Drain Current – Pulsed (Note 1) | 13* | A |
| V_{GSS} | Gate-Source voltage | ± 30 | V |
| E_{AS} | Single Pulsed Avalanche Energy (Note 2) | 46 | mJ |
| I_{AR} | Avalanche Current (Note 1) | 1 | A |
| E_{AR} | Repetitive Avalanche Energy (Note 1) | 0.2 | mJ |
| dv/dt | Peak Diode Recovery dv/dt (Note 3) | 15 | V/ns |
| $dvds/dt$ | Drain Source voltage slope ($V_{ds}=480\text{V}$) | 50 | V/ns |
| P_D | Power Dissipation ($T_C = 25\text{ }^{\circ}\text{C}$) | 37 | W |
| T_J, T_{STG} | Operating and Storage Temperature Range | -55 to +150 | $^{\circ}\text{C}$ |
| T_L | Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds | 300 | $^{\circ}\text{C}$ |

* Drain current limited by maximum junction temperature.

Thermal Characteristics

| Symbol | Parameter | Value | Unit |
|-----------------|---|-------|-----------------------------|
| $R_{\theta JC}$ | Thermal Resistance, Junction-to-Case | 3.41 | $^{\circ}\text{C}/\text{W}$ |
| $R_{\theta CS}$ | Thermal Resistance, Case-to-Sink Typ. | 0.5 | $^{\circ}\text{C}/\text{W}$ |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | 62 | $^{\circ}\text{C}/\text{W}$ |

Electrical Characteristics TC = 25°C unless otherwise noted

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|--|---|--|-----|------|------|----------|
| Off Characteristics | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0V, I_D = 250\mu A, T_J = 25^\circ C$ | 600 | -- | -- | V |
| | | $V_{GS} = 0V, I_D = 250\mu A, T_J = 150^\circ C$ | -- | 650 | -- | V |
| $\Delta BV_{DSS} / \Delta T_J$ | Breakdown Voltage Temperature Coefficient | $I_D = 250\mu A$, Referenced to 25°C | -- | 0.6 | -- | V/°C |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = 600V, V_{GS} = 0V$ $T_C = 25^\circ C$ | -- | -- | 1 | μA |
| | | $V_{DS} = 600V, V_{GS} = 0V$ $T_C = 150^\circ C$ | -- | 10 | -- | μA |
| I_{GSSF} | Gate-Body Leakage Current, Forward | $V_{GS} = 30V, V_{DS} = 0V$ | -- | -- | 100 | nA |
| I_{GSSR} | Gate-Body Leakage Current, Reverse | $V_{GS} = -30V, V_{DS} = 0V$ | -- | -- | -100 | nA |
| On Characteristics | | | | | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = 250\mu A$ | 2.5 | -- | 4.5 | V |
| $R_{DS(on)}$ | Static Drain-Source On-Resistance | $V_{GS} = 10V, I_D = 2.5A$ | -- | 0.77 | 0.85 | Ω |
| g_{FS} | Forward Trans conductance | $V_{DS} = 40V, I_D = 5A$ (Note 4) | -- | 4 | -- | S |
| R_g | Gate resistance | f=1 MHz, open drain | - | 3.5 | - | Ω |
| Dynamic Characteristics | | | | | | |
| C_{iss} | Input Capacitance | $V_{DS} = 25V, V_{GS} = 0V,$ $f = 1.0MHz$ | -- | 320 | -- | pF |
| C_{oss} | Output Capacitance | | -- | 75 | -- | pF |
| C_{rss} | Reverse Transfer Capacitance | | -- | 5 | -- | pF |
| Switching Characteristics | | | | | | |
| $t_{d(on)}$ | Turn-On Delay Time | $V_{DD} = 400V, I_D = 2.5A$ $R_G = 20\Omega$ (Note 4, 5) | -- | 10 | -- | ns |
| t_r | Turn-On Rise Time | | -- | 8 | -- | ns |
| $t_{d(off)}$ | Turn-Off Delay Time | | -- | 60 | -- | ns |
| t_f | Turn-Off Fall Time | | -- | 13 | -- | ns |
| Q_g | Total Gate Charge | $V_{DS} = 480V, I_D = 2.5A$ $V_{GS} = 10V$ (Note 4, 5) | -- | 15 | -- | nC |
| Q_{gs} | Gate-Source Charge | | -- | 3 | -- | nC |
| Q_{gd} | Gate-Drain Charge | | -- | 6 | -- | nC |
| Drain-Source Diode Characteristics and Maximum Ratings | | | | | | |
| I_S | Maximum Continuous Drain-Source Diode Forward Current | -- | -- | 5 | A | |
| I_{SM} | Maximum Pulsed Drain-Source Diode Forward Current | -- | -- | 13 | A | |
| V_{SD} | Drain-Source Diode Forward Voltage | $V_{GS} = 0V, I_F = 2.5A$ | -- | 0.9 | 1.5 | V |
| t_{rr} | Reverse Recovery Time | $V_{GS} = 0V, I_F = 2.5A$ $dI_F/dt = 100A/\mu s$ (Note 4) | -- | 180 | -- | ns |
| Q_{rr} | Reverse Recovery Charge | | -- | 1.5 | -- | μC |

NOTES:

- Repetitive Rating: Pulse width limited by maximum junction temperature
- $I_{AS}=1A, V_{DD}=50V$, Starting $TJ=25^\circ C$
- $I_{SD}\leq 5A, di/dt \leq 200A/\mu s, V_{DD} \leq BV_{DSS}$, Starting $TJ = 25^\circ C$
- Pulse Test: Pulse width $\leq 300\mu s$, Duty Cycle $\leq 2\%$
- Essentially Independent of Operating Temperature Typical Characteristics

Typical Performance Characteristics

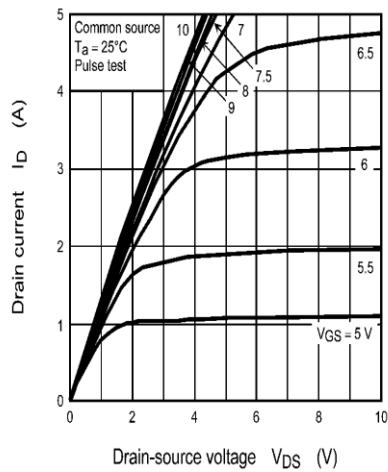


Figure 1: On-Region Characteristics@25°C

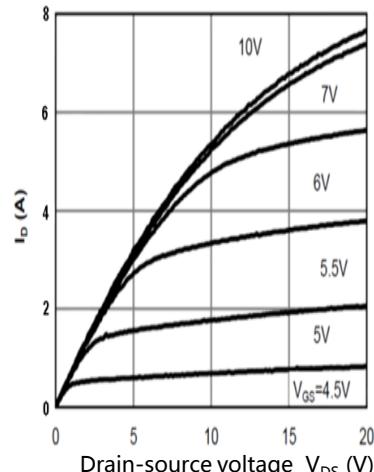


Figure 2: On-Region Characteristics@125°C

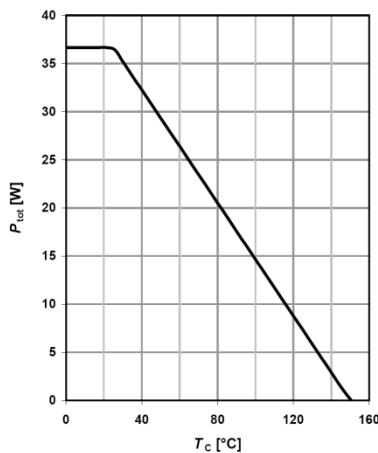


Figure 3: Power Dissipation

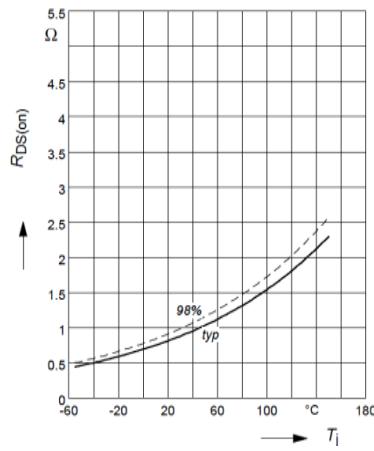


Figure 4: On-Resistance vs. Junction Temperature

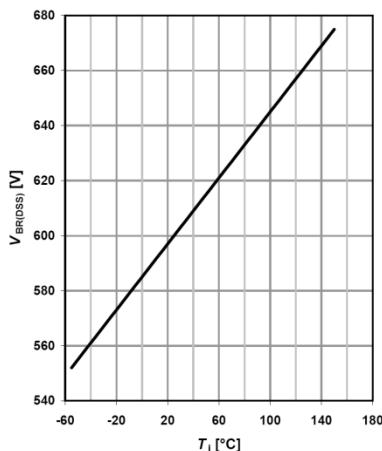


Figure 5: Break Down vs. Junction Temperature

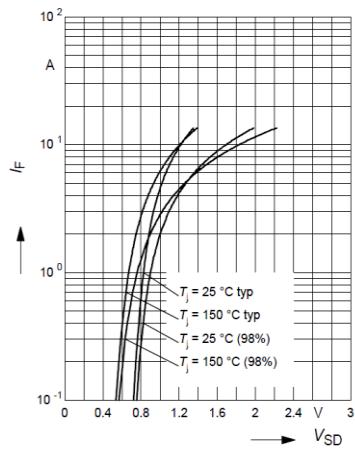


Figure 6: Body-Diode Characteristics

Typical Performance Characteristics

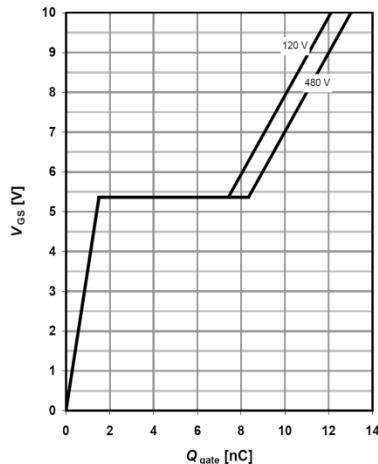


Figure 7: Gate-Charge Characteristics

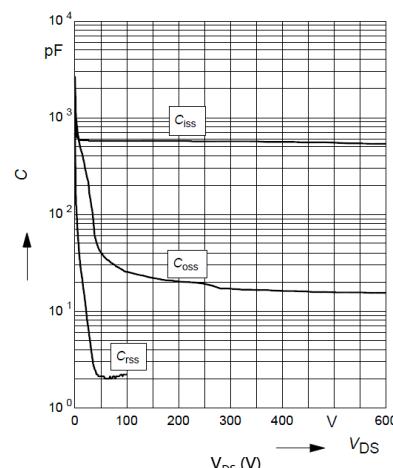


Figure 8: Capacitance Characteristics

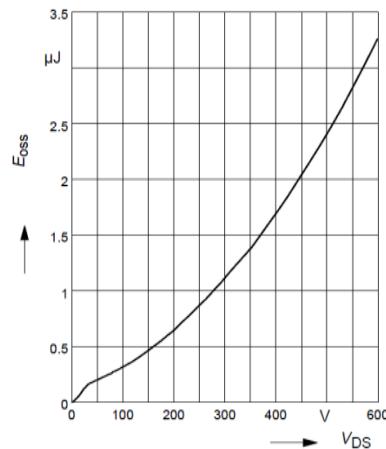
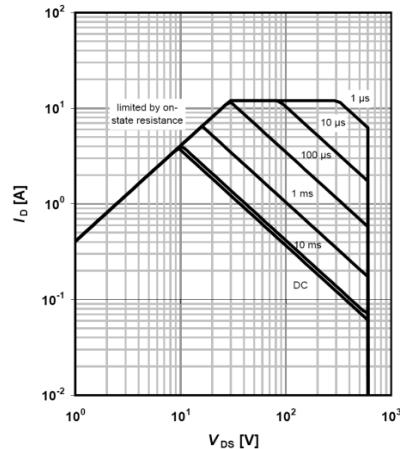
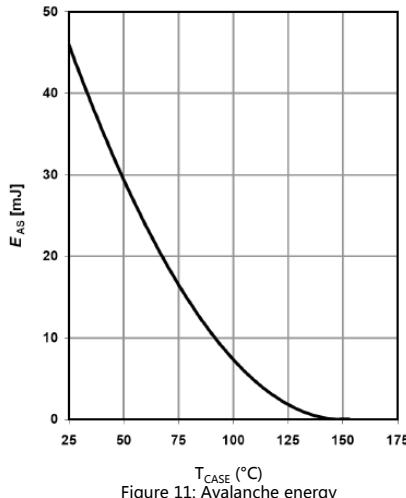
Figure 9: C_{oss} stored EnergyFigure 10: Maximum Forward Biased Safe Operating Area $T_c=25$ (°C).

Figure 11: Avalanche energy

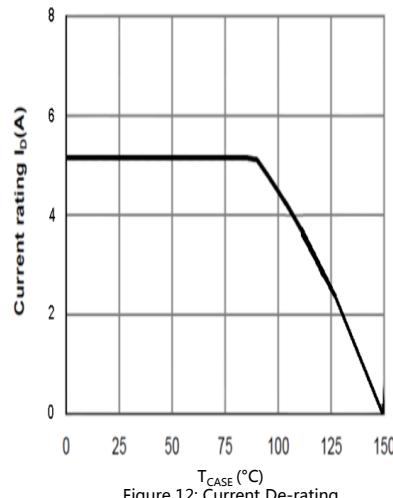


Figure 12: Current De-rating

Typical Performance Characteristics

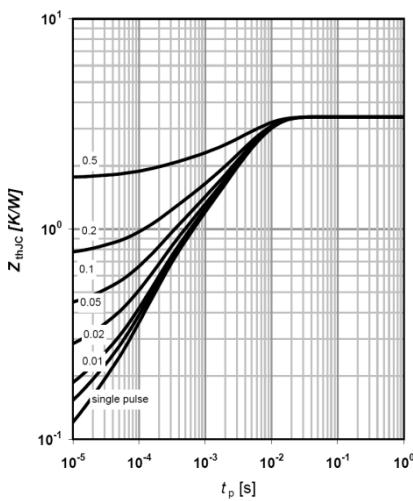


Figure 13: Maximum Transient Thermal Impedance

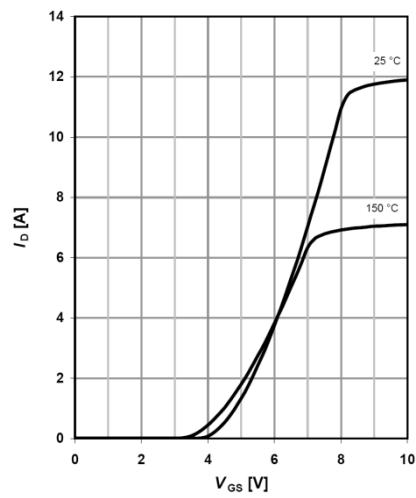
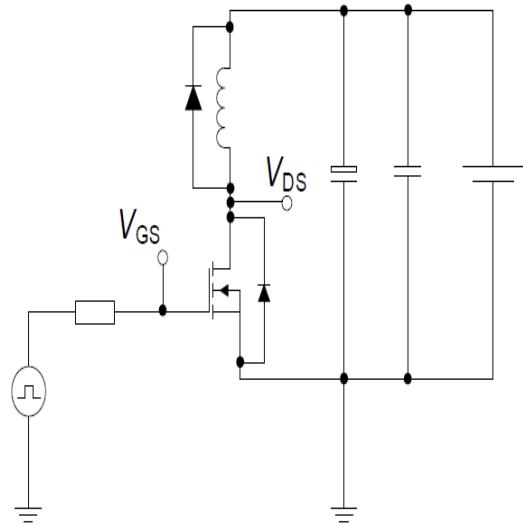


Figure 14: Typ. transfer characteristics

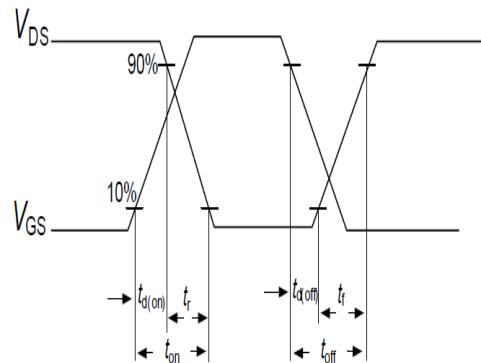
Test circuits

Switching times test circuit and waveform for inductive load

Switching times test circuit for inductive load

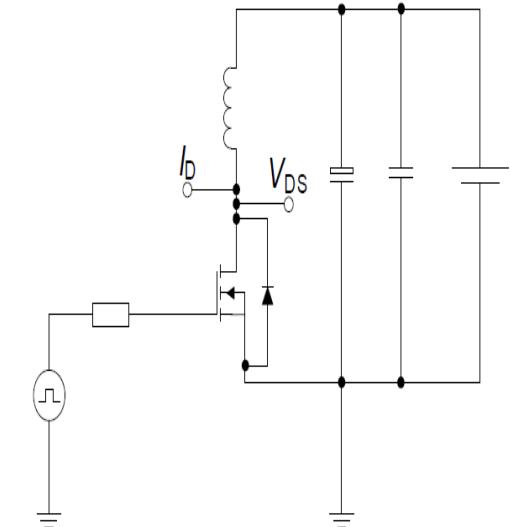


Switching time waveform

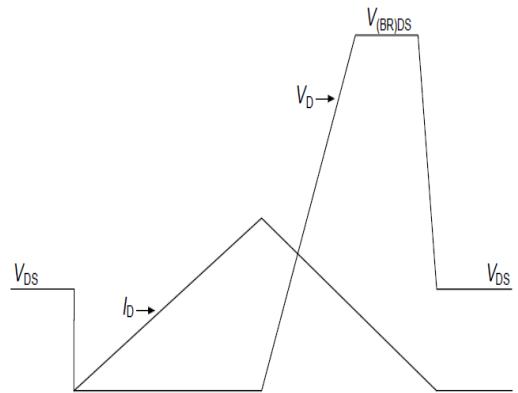


Unclamped inductive load test circuit and waveform

Unclamped inductive load test circuit



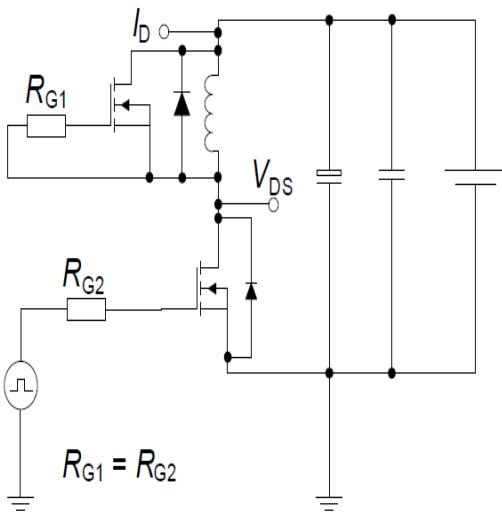
Unclamped inductive waveform



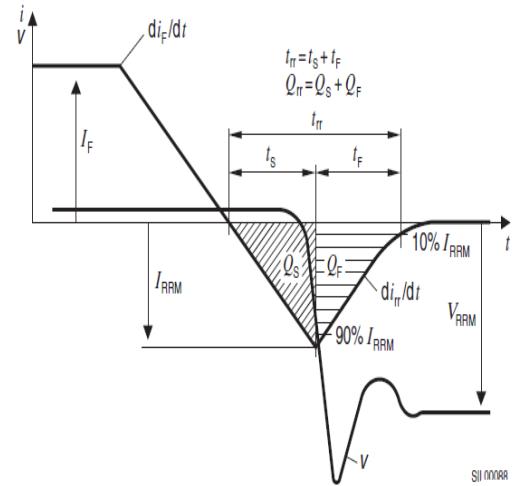
Test circuits

Test circuit and waveform for diode characteristics

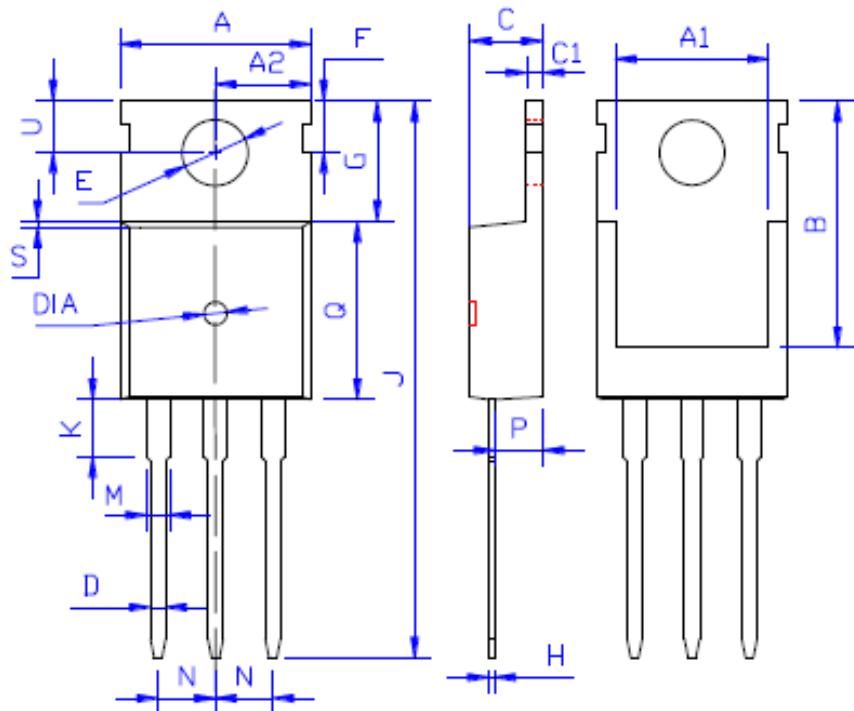
Test circuit for diode characteristics



Diode recovery waveform



Package Outline TO-220



| DIM | MILLIMETERS |
|-----|---------------------------|
| A | 10.00±0.30 |
| A1 | 8.00±0.30 |
| A2 | 5.00±0.30 |
| B | 13.20±0.40 |
| C | 4.50±0.20 |
| C1 | 1.30±0.20 |
| D | 0.80±0.20 |
| E | 3.60±0.20 |
| F | 3.00±0.30 |
| G | 6.60±0.40 |
| H | 0.50±0.20 |
| J | 28.88±0.50 |
| K | 3.00±0.30 |
| M | 1.30±0.30 |
| N | Typical 2.54 |
| P | 2.40±0.40 |
| Q | 9.20±0.40 |
| S | 0.25±0.15 |
| T | 0.25±0.15 |
| U | 2.80±0.30 |
| DIA | 寬 1.50±0.10 深 0.50 MAX |